

forward and inverse radiometric models for translucent materials

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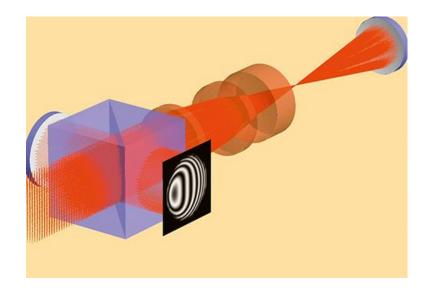
forward problem

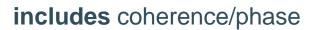
using radiometric models to simulate translucent materials

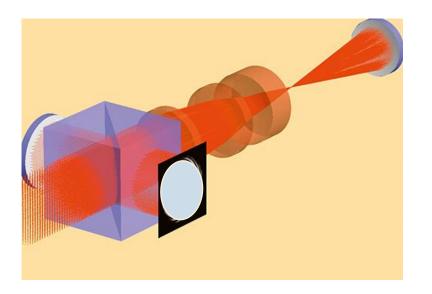


what are radiometric models?

model radiant energy propagation through a system/material without explicitly including phase/coherence



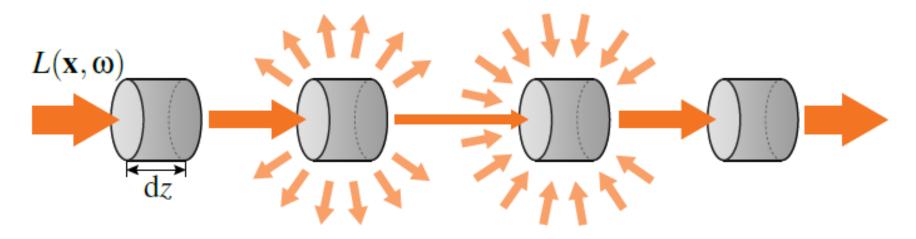




ignores coherence/phase



radiometric models are based on the radiative transfer equation (RTE)



(a) Absorption (b) Out-scattering (c) In-scattering (d) Emission

$$(\vec{\omega} \cdot \nabla) L(\boldsymbol{x}, \vec{\omega}) = -\mu_a(\boldsymbol{x}) L(\boldsymbol{x}, \vec{\omega}) - \mu_s(\boldsymbol{x}) L(\boldsymbol{x}, \vec{\omega}) + \mu_s(\boldsymbol{x}) \int_{4\pi} p(\boldsymbol{x}, \vec{\omega}', \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}') + l_e(\boldsymbol{x}, \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}', \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}, \vec{\omega}, \vec{\omega}', \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}, \vec{\omega}, \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}, \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}, \vec{\omega}) L(\boldsymbol{x}, \vec{\omega}, \vec{\omega},$$



the RTE depends on the scattering and absorption coefficients ...



absorption/scattering coefficient: probability of absorption/scattering per unit distance

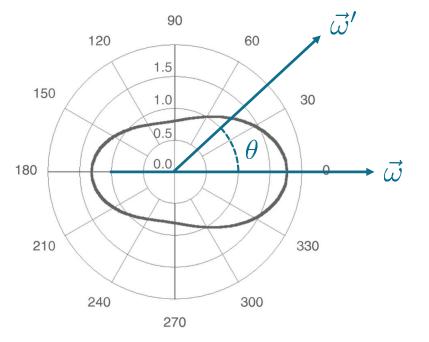


... and on the phase function

$$p(\boldsymbol{x}, \vec{\omega}, \vec{\omega}', \lambda) \longrightarrow p(\theta, \lambda)$$

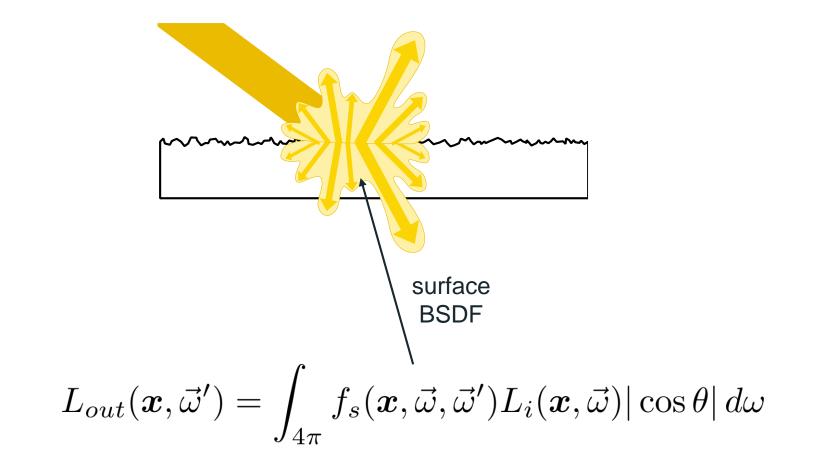
phase function:

angular probability distribution of the scattered light





surface scattering is a boundary condition to the RTE



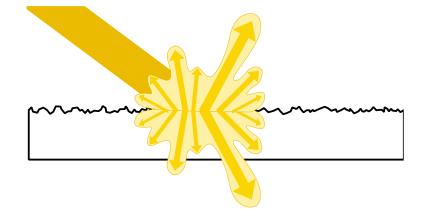


the surface BSDF does not describe bulk scattering

surface BSDF:

proportionality factor of scattered radiance to the incident irradiance

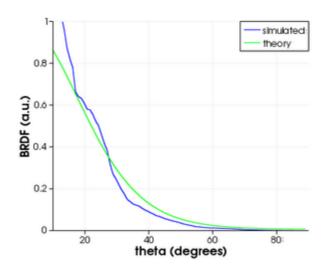
$$f_s(\boldsymbol{x}, \vec{\omega}, \vec{\omega}') = \frac{L_{out}(\boldsymbol{x}, \vec{\omega}')}{E_{in}(\boldsymbol{x}, \vec{\omega})}$$



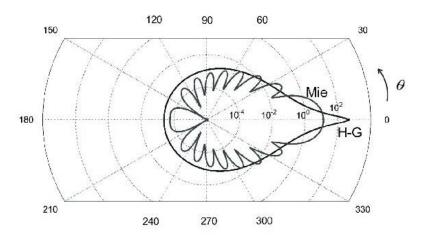


certain phase effects are included in radiometric models

surface BSDF models wave scattering



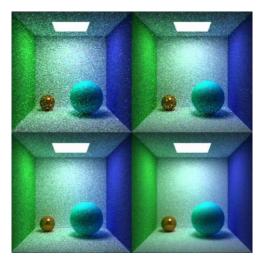
wave effects are included in the phase function

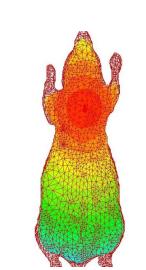


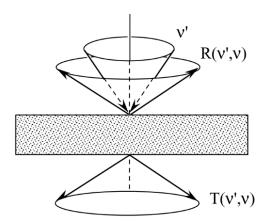


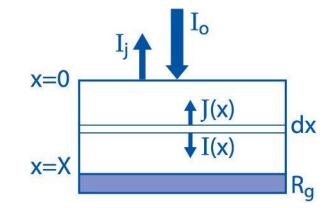
there are multiple methods available to solve the RTE

Monte Carlo ray tracing finite element methods adding-doubling method Kubelka-Munk model



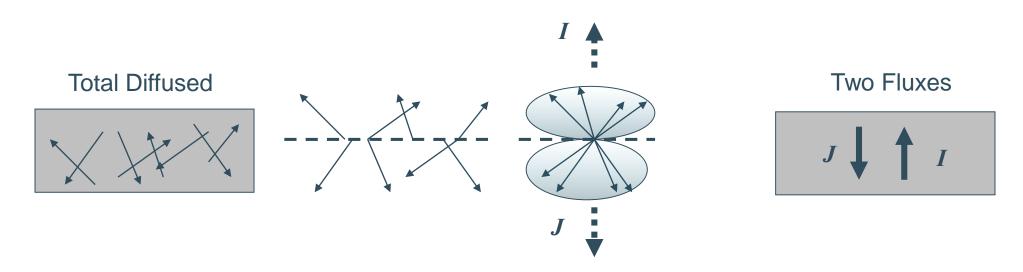








Kubelka-Munk model is applicable to many sample types

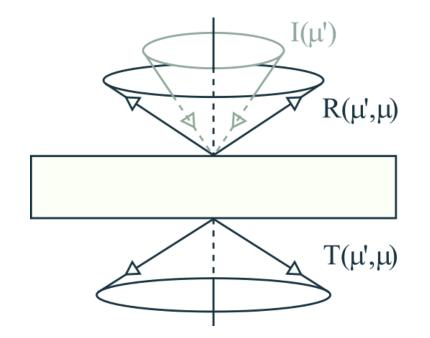


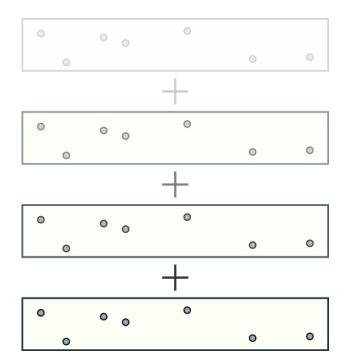
diffusely illuminated thick scattering samples

thin scattering samples in which light distribution is partially diffused absorbing media in which light distribution varies with degree of absorption



adding-doubling can simulate radiant intensity distributions







inverse problem

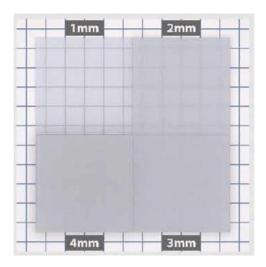
estimating the scattering parameters of translucent materials



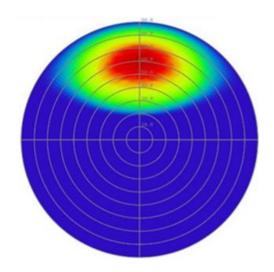
what scattering properties do we need to estimate?

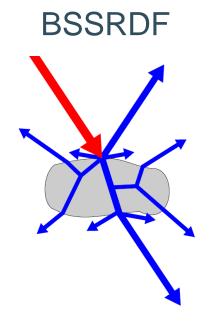
 $\mu_a(\lambda) \quad \mu_s(\lambda) \quad p(\theta, \lambda) \quad f_s(\vec{\omega}, \vec{\omega}')$

appearance



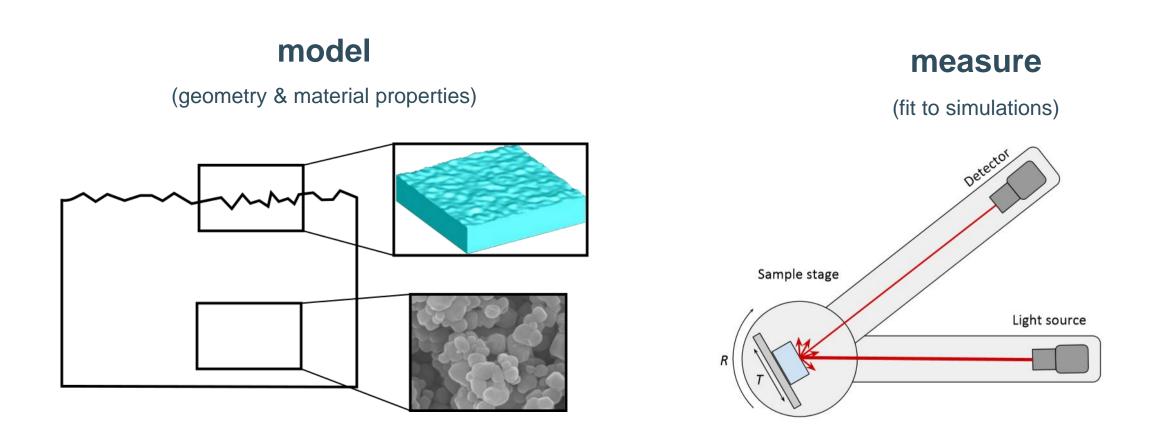
optical performance





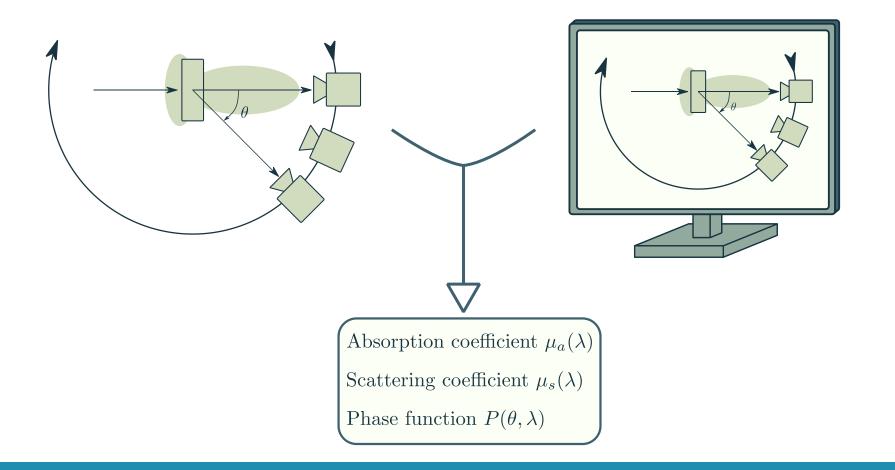


how do we estimate the surface and bulk properties?



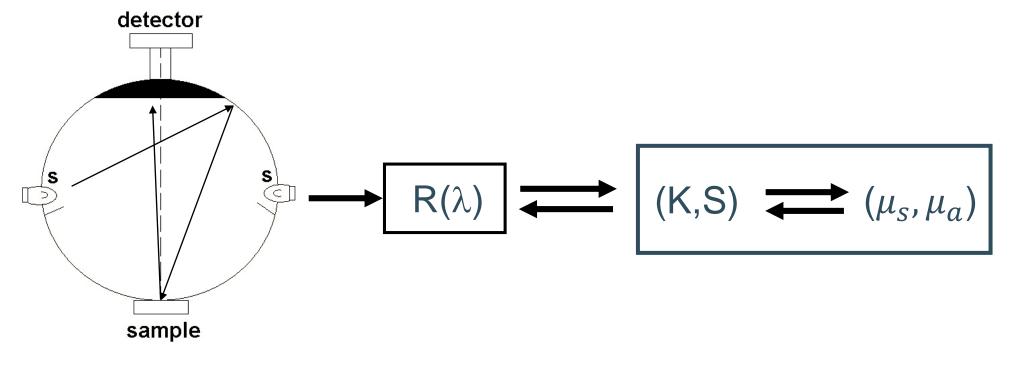


fitting simulations to measurements



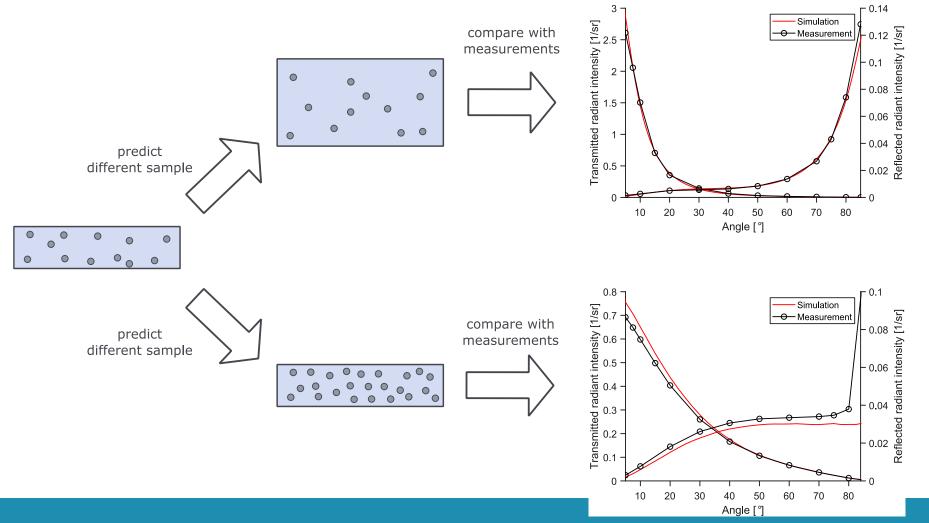


spectral reflection and the Kubelka-Munk method





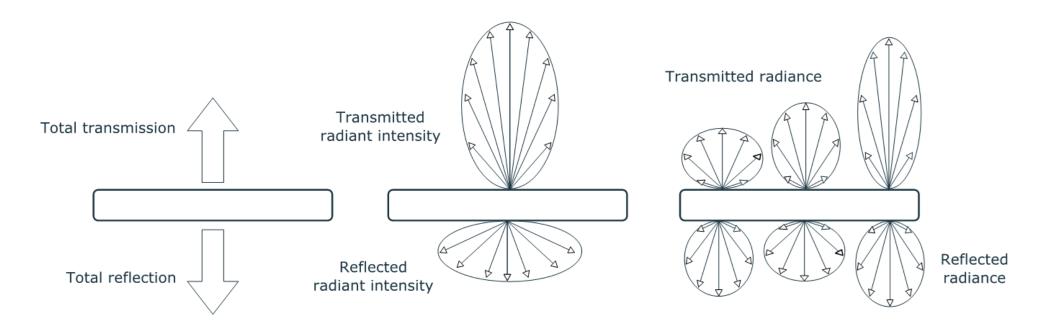
using radiant intensity with IAD improves generalization



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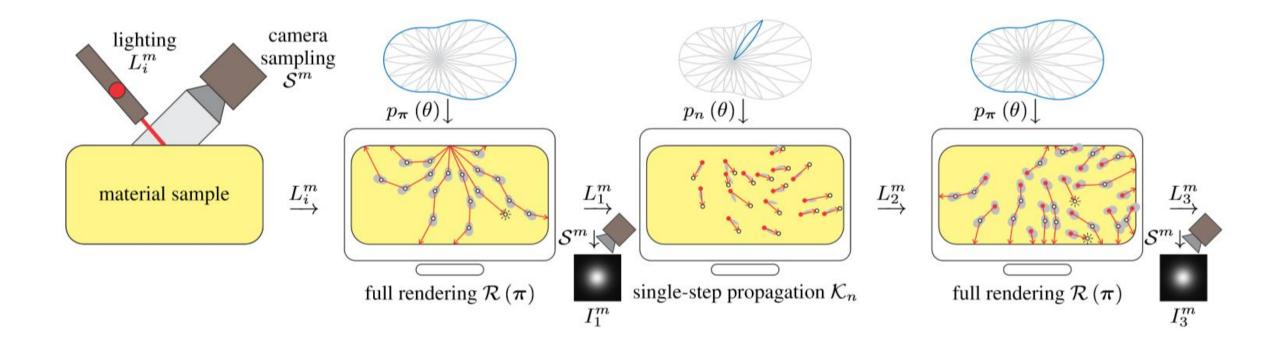
more complex measurements can further improve accuracy



similarity theory: for very opaque samples, different sets of parameter produce indistinguishable images or optical performance



using radiance measurements is one such example





obtaining scattering properties for combined scattering samples is not trivial but BSSRDF may help

